


<b>Search Notes</b>  	<b>Application/Control No.</b>  10603099	<b>Applicant(s)/Patent Under Reexamination</b>  ZABAWSKYJ ET AL.
	<b>Examiner</b>  Thier, Michael T	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
	updated	2/12/2008	MTT

SEARCH NOTES		
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INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner